

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/531,208	UEDA ET AL.	
Examiner	Art Unit	
Sin J. Lee	1795	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
Structure searches were done by EIC	12/15/2008	SJL
east text search	12/14/2008	SJL
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